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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.		
09/234,233	01/20/1999	WEIMIN LI	M122-1035	6381		
21567	7590 10/07/2004	•	EXAMINER			
WELLS ST. JOHN P.S.			VU, DAVID			
SPOKANE,	T AVENUE, SUITE 1300 WA 99201		ART UNIT	PAPER NUMBER		
,			2818			
			DATE MAILED: 10/07/2004			

Please find below and/or attached an Office communication concerning this application or proceeding.



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EXAMINER

ART UNIT PAPER

45

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**Commissioner for Patents** 

Attached is a copy of the IDS dated 06/25/04 which has been considered by the examiner.

Supervisory Patent Examiner Technology Center 2800

\$100.For PTO-1449		-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKETNO. MI22-1035			SERIAL NO. 09/234,233		
9	2004	LIST OF ART CITED BY A			Y APPLICANT		APPLICANT Welmin II				
				FILING DATE January 20, 1999		GROUP 2818			_		
d	U.S. PATENT DOCUMENTS										
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	EXAMINER Gradano				DATE	DATE CONSIDERED 69/29/64					
	*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										

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